Se	arch	Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination
10/755,292	HAYASHI ET AL.
Examiner	Art Unit
Elias Desta	2857

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	SEARCHED		
Class	Subclass	Date	Examiner
702	60,179,18 2-186,188	12/7/2005	E.D
73	112	12/7/2005	E.D
700	108,286	12/7/2005	E.D
705	412	12/7/2005	E.D
340	286.01	12/7/2005	E.D
60	403	12/7/2005	E.D ·
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
· 702	60,184 188	12/7/2005	. E.D
73	112	12/7/2005	`E.D
700	108,286	12/7/2005	E.D
705/412; 3	340/286.01	12/7/2005	E.D

SEARCH NOT (INCLUDING SEARCH		)
	DATE	EXMR
Method of search: EAST, IEEE Explore, YAHOO, GOOGLE, and CRC	12/17/2005	E.D ·
Consulted: Hal W., cl. 702, au:2857 (parent case), Frank Elliot, class 700, au: 2125	7/22/2004	E.D
Text or key word searches: see attachment.	12/7/2005	E.D